National Semiconductor

December 1994

54F/74F08
Quad 2-Input AND Gate

General Description

This device contains four independent gates, each of which performs the logic AND function.

Features

- Guaranteed 4000V minimum ESD protection

Ordering Code: See Section 0

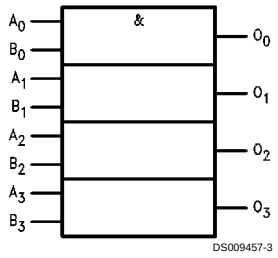
Commercial	Military	Package Number	Package Description
74F08PC		N14A	14-Lead (0.300" Wide) Molded Dual-In-Line
	54F08DM (Note 2)	J14A	14-Lead Ceramic Dual-In-Line
74F08SC (Note 1)		M14A	14-Lead (0.150" Wide) Molded Small Outline, JEDEC
74F08SJ (Note 1)		M14D	14-Lead (0.300" Wide) Molded Small Outline, EIAJ
	54F08FM (Note 2)	W14B	14-Lead Cerpack
	54F08LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C

Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

Logic Symbol

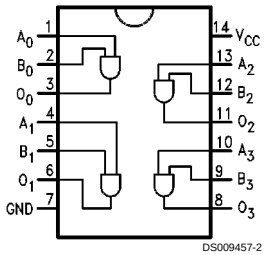
IEEE/IEC



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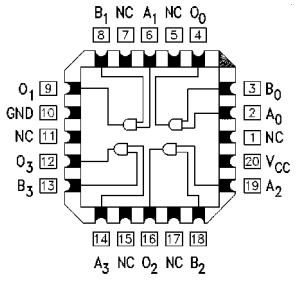
Connection Diagrams

Pin Assignment for DIP, SOIC and Flatpak



DS009457-2

Pin Assignment for LCC



DS009457-1

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Unit Loading/Fan Out

See Section 0 for U.L. definitions

DSXXX

Pin Names	Description	54F/74F	
		U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
A_n, B_n	Inputs	1.0/1.0	20 µA/−0.6 mA
O_n	Outputs	50/33.3	−1 mA/20 mA

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Absolute Maximum Ratings (Note 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Storage Temperature	−65˚C to +150˚C
Ambient Temperature under Bias	−55˚C to +125˚C
Junction Temperature under Bias	−55˚C to +175˚C
Plastic	−55˚C to +150˚C
V_{CC} Pin Potential to Ground Pin	−0.5V to +7.0V
Input Voltage (Note 4)	−0.5V to +7.0V
Input Current (Note 4)	−30 mA to +5.0 mA
Voltage Applied to Output in HIGH State (with V_{CC} = 0V)	
Standard Output	−0.5V to V_{CC}
TRI-STATE® Output	−0.5V to +5.5V
Current Applied to Output in LOW State (Max)	twice the rated I_{OL} (mA)
ESD Last Passing Voltage (Min)	4000V

Recommended Operating Conditions

Free Air Ambient Temperature	
Military	−55˚C to +125˚C
Commercial	0˚C to +70˚C
Supply Voltage	
Military	+4.5V to +5.5V
Commercial	+4.5V to +5.5V

Note 3: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 4: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter		54F/74F			Units	V_{CC}	Conditions
			Min	Typ	Max			
V_{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V_{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V_{CD}	Input Clamp Diode Voltage				−1.2	V	Min	I_{IN} = −18 mA
V_{OH}	Output HIGH	54F 10% V_{CC}	2.5					I_{OH} = −1 mA
	Voltage	74F 10% V_{CC}	2.5			V	Min	I_{OH} = −1 mA
		74F 5% V_{CC}	2.7					I_{OH} = −1 mA
V_{OL}	Output LOW	54F 10% V_{CC}			0.5	V	Min	I_{OL} = 20 mA
	Voltage	74F 10% V_{CC}			0.5			I_{OL} = 20 mA
I_{IH}	Input HIGH	54F			20.0	µA	Max	V_{IN} = 2.7V
	Current	74F			5.0			
I_{BVI}	Input HIGH Current	54F			100	µA	Max	V_{IN} = 7.0V
	Breakdown Test	74F			7.0			
I_{CEX}	Output HIGH	54F			250	µA	Max	V_{OUT} = V_{CC}
	Leakage Current	74F			50			
V_{ID}	Input Leakage	74F	4.75			V	0.0	I_{ID} = 1.9 µA
	Test							All Other Pins Grounded
I_{OD}	Output Leakage	74F			3.75	µA	0.0	V_{IOD} = 150 mV
	Circuit Current							All Other Pins Grounded
I_{IL}	Input LOW Current				−0.6	mA	Max	V_{IN} = 0.5V
I_{OS}	Output Short-Circuit Current		−60		−150	mA	Max	V_{OUT} = 0V
I_{CCH}	Power Supply Current			5.5	8.3	mA	Max	V_O = HIGH
I_{CCL}	Power Supply Current			8.6	12.9	mA	Max	V_O = LOW

AC Electrical Characteristics

See Section 0 for Waveforms and Load Configurations

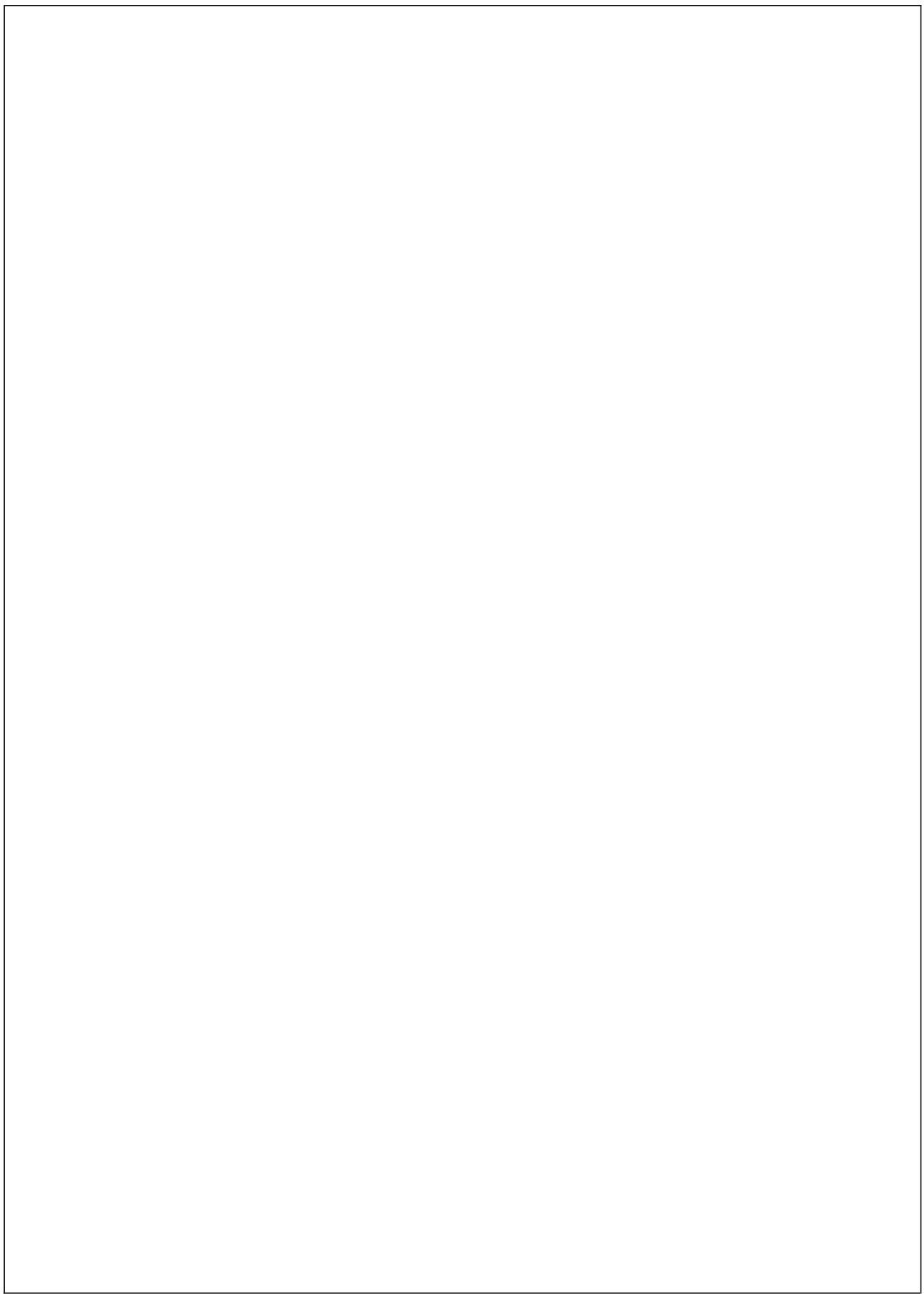
Symbol	Parameter	74F T_A = +25˚C, V_{CC} = +5.0V, C_L = 50 pF			54F T_A, V_{CC} = Mil, C_L = 50 pF		74F T_A, V_{CC} = Com, C_L = 50 pF		Units	Fig. No.
		Min	Typ	Max	Min	Max	Min	Max		
t_{PLH}	Propagation Delay	3.0	4.2	5.6	2.5	7.5	3.0	6.6	ns	⧫⧫-⧫⧫
t_{PHL}	A_n, B_n to O_n	2.5	4.0	5.3	2.0	7.5	2.5	6.3		

DSXXX

DSXXX

Book Extract End

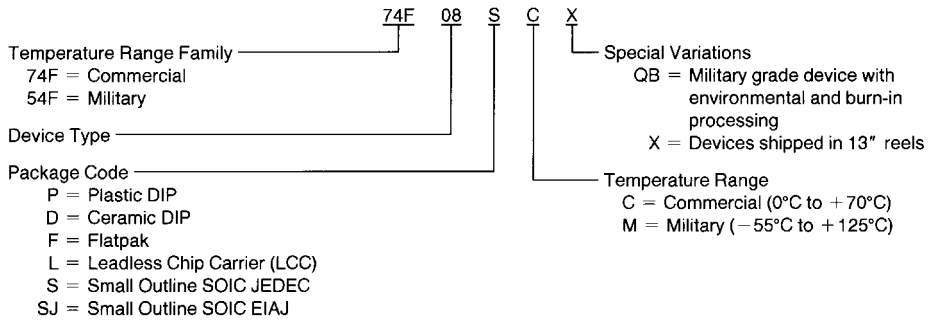
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PrintDate=1997/08/26 PrintTime=15:23:52 9460 ds009457 Rev. No. 1 cmserv **Proof**

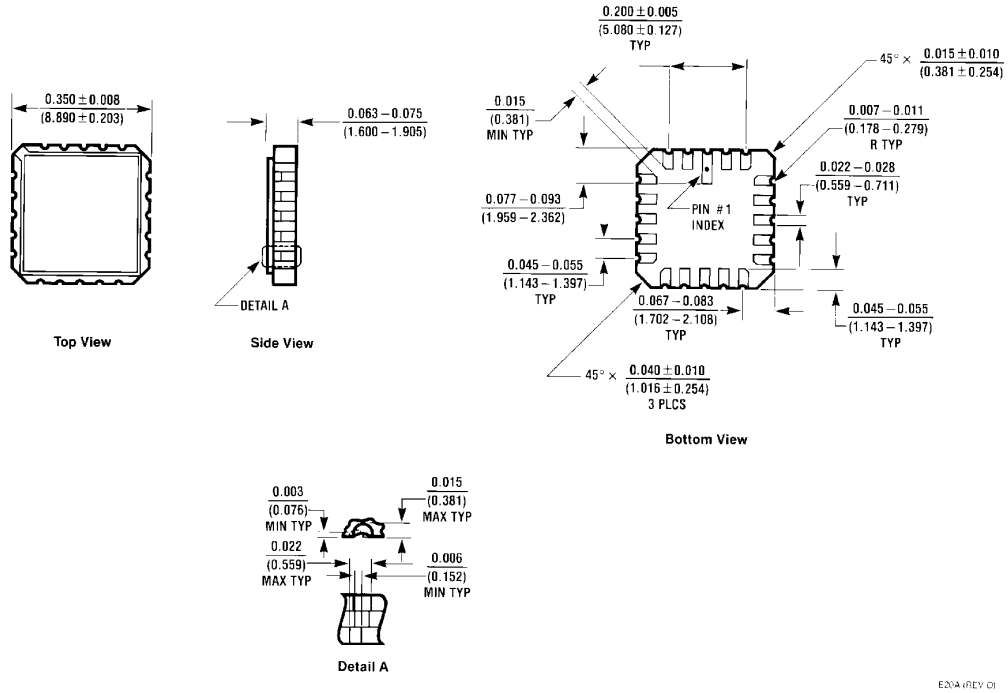
Ordering Information

The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:



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Physical Dimensions inches (millimeters) unless otherwise noted

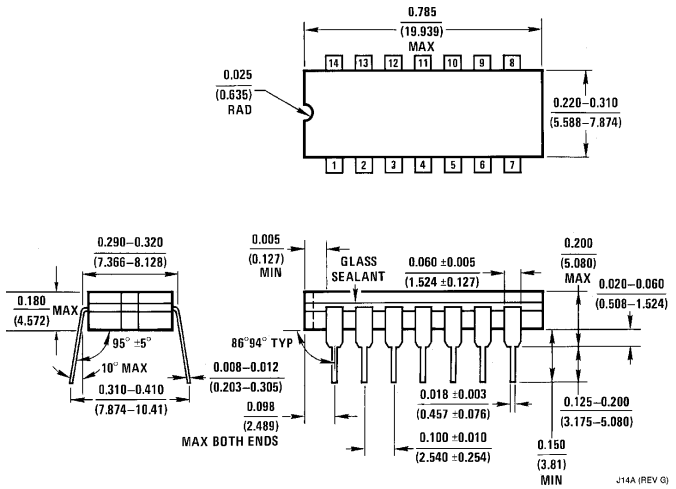


E20A (REV O)

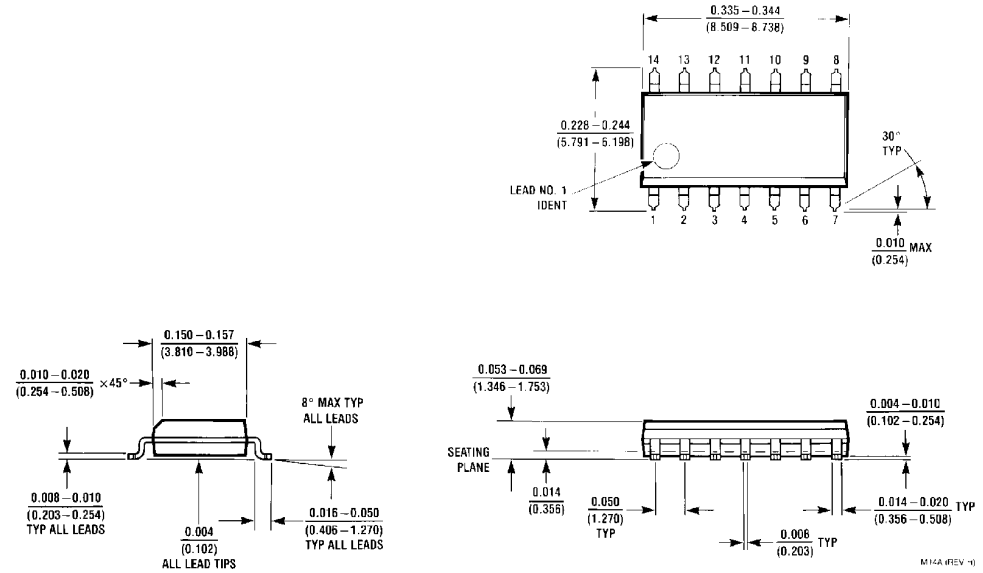
20-Lead Ceramic Leadless Chip Carrier (L)
NS Package Number E20A

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Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



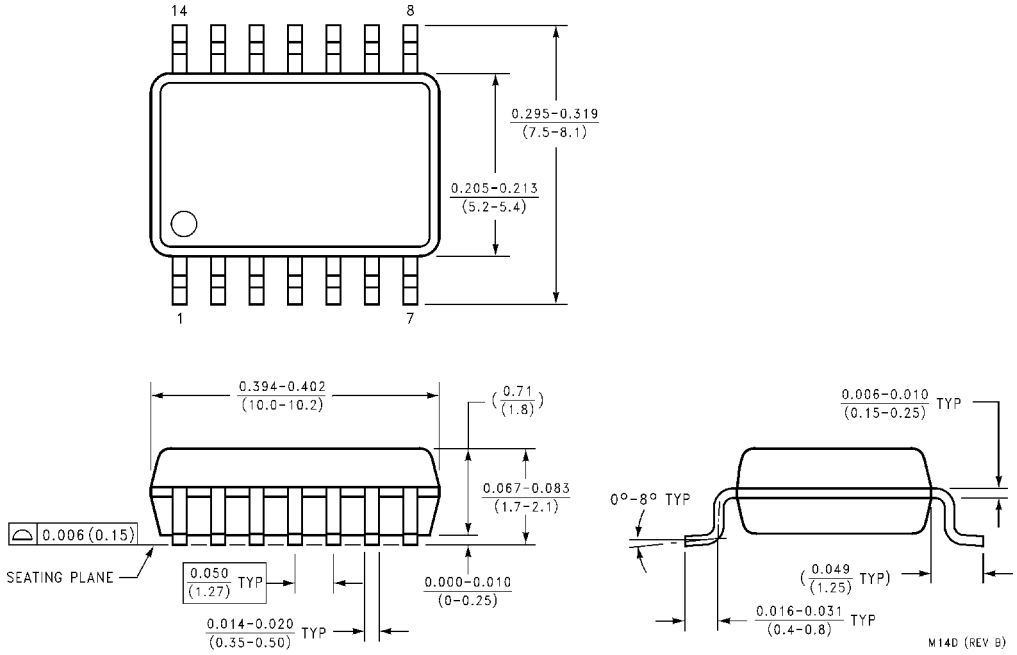
14-Lead Ceramic Dual-In-Line Package (D)
NS Package Number J14A



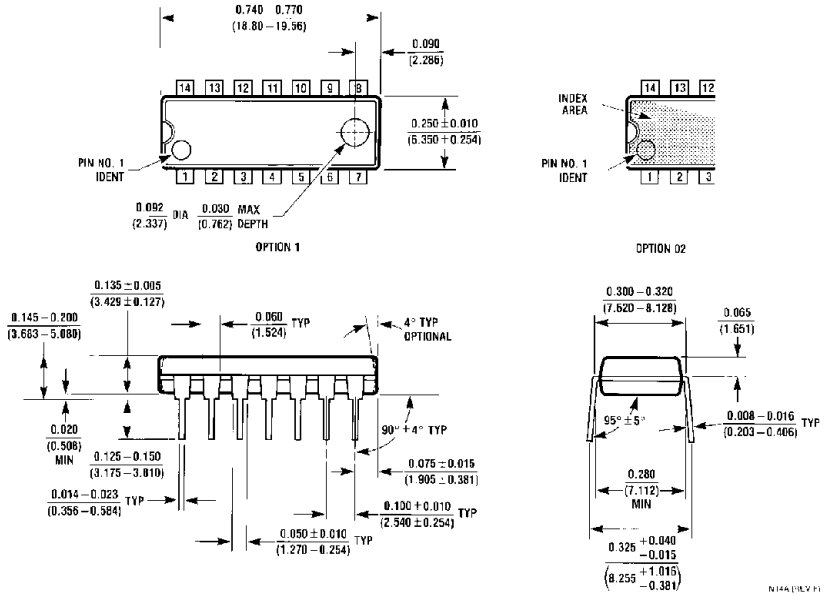
14-Lead (0.150" Wide) Molded Small Outline, JEDEC (S)
NS Package Number M14A

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Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



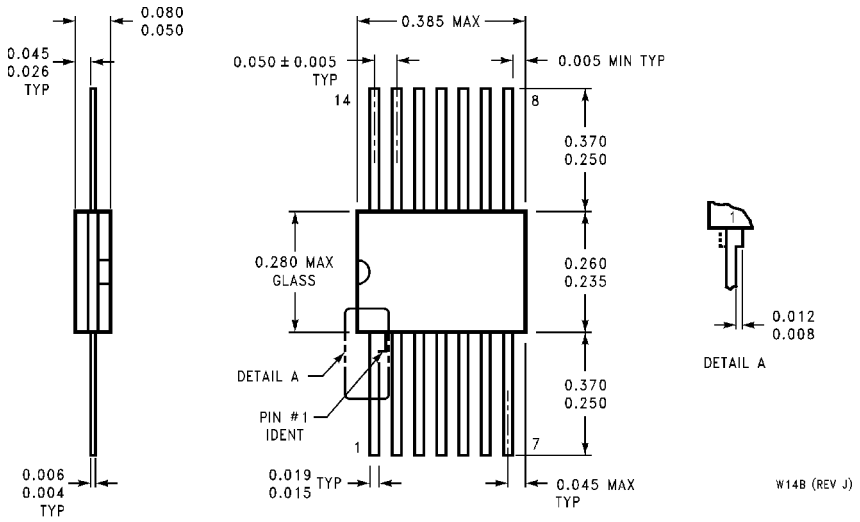
14-Lead (0.300" Wide) Molded Small Outline, EIAJ (SJ)
NS Package Number M14D



14-Lead (0.300" Wide) Molded Dual-In-Line Package (P)
NS Package Number N14A

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Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Ceramic Flatpak (F)
NS Package Number W14B

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